



N-Channel Power MOSFET

600V, 4A, 0.9Ω

FEATURES

- Super-Junction technology
- High performance due to small figure-of-merit
- High ruggedness performance
- High commutation performance
- 100% UIL tested
- Pb-free plating
- Compliant to RoHS Directive 2011/65/EU and in accordance to WEEE 2002/96/EC
- Halogen-free according to IEC 61249-2-21

KEY PERFORMANCE PARAMETERS			
PARAMETER VALUE UNI			
V_{DS}	600	V	
R _{DS(on)} (max)	0.9	Ω	
Q_{g}	9.6	nC	





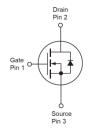


APPLICATIONS

- Power Supply
- Lighting







ABSOLUTE MAXIMUM RATINGS (T _A = 25°C unless otherwise noted)				
PARAMETER		SYMBOL	LIMIT	UNIT
Drain-Source Voltage		V _{DS}	600	V
Gate-Source Voltage		V _{GS}	±30	V
Continuous Drain Current (Note 1)	T _C = 25°C		4	А
	T _C = 100°C	I _D	2.4	А
Pulsed Drain Current (Note 2)		I _{DM}	12	А
Total Power Dissipation @ T _C = 25°C	C	P _{DTOT}	36.8	W
Single Pulsed Avalanche Energy (Not	e 3)	E _{AS}	42.3	mJ
Single Pulsed Avalanche Current (No	te 3)	I _{AS}	1.3	А
Operating Junction and Storage Ten	nperature Range	T _J , T _{STG}	- 55 to +150	°C

THERMAL PERFORMANCE			
PARAMETER	SYMBOL	LIMIT	UNIT
Junction to Case Thermal Resistance	R _{eJC}	3.4	°C/W
Junction to Ambient Thermal Resistance	$R_{\Theta JA}$	62	°C/W

Thermal Performance Note: $R_{\Theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistances. The case-thermal reference is defined at the solder mounting surface of the drain pins. $R_{\Theta JA}$ is guaranteed by design while $R_{\Theta CA}$ is determined by the user's board design. $R_{\Theta JA}$ shown below for single device operation on FR-4 PCB in still air.

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ELECTRICAL SPECIFICAT	ELECTRICAL SPECIFICATIONS (T _A = 25°C unless otherwise noted)					
PARAMETER	CONDITIONS	SYMBOL	MIN	TYP	MAX	UNIT
Static						
Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu A$	BV _{DSS}	600			V
Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	$V_{GS(TH)}$	2	3.3	4	V
Gate Body Leakage	$V_{GS} = \pm 30V$, $V_{DS} = 0V$	I _{GSS}			±100	nA
Zero Gate Voltage Drain Current	$V_{DS} = 600V, V_{GS} = 0V$	I _{DSS}			1	μΑ
Drain-Source On-State Resistance (Note 4)	V _{GS} = 10V, I _D = 1.2A	R _{DS(on)}		0.69	0.9	Ω
Dynamic (Note 5)	l	l		l	L	
Total Gate Charge	$V_{DS} = 380V, I_D = 4A,$ $V_{GS} = 10V$	Qg		9.6		
Gate-Source Charge		Q _{gs}		2.0		nC
Gate-Drain Charge		Q_{gd}		4.5		
Input Capacitance	$V_{DS} = 100V, V_{GS} = 0V,$	C _{iss}		315		. =
Output Capacitance	f = 1.0MHz	C _{oss}		46.4		pF
Gate Resistance	F = 1MHz, open drain	R_g		3.2		Ω
Switching (Note 6)						
Turn-On Delay Time	$V_{DD} = 380V,$ $R_{GEN} = 25\Omega,$ $I_{D} = 4A, V_{GS} = 10V,$	t _{d(on)}		18		
Turn-On Rise Time		t _r		10		
Turn-Off Delay Time		t _{d(off)}		36.4		ns
Turn-Off Fall Time		t _f		8		
Source-Drain Diode						
Forward Voltage (Note 4)	I _S = 4A, V _{GS} = 0V	V _{SD}			1.4	V
Reverse Recovery Time	$V_R = 100V, I_S = 4A$ $dI_F/dt = 100A/\mu s$	t _{rr}		185.5		ns
Reverse Recovery Charge		Q _{rr}		1.38		μC

Notes:

- 1. Current limited by package.
- 2. Pulse width limited by the maximum junction temperature.
- 3. L = 50mH, $I_{AS} = 1.3A$, $V_{DD} = 50V$, $R_G = 25\Omega$, Starting $T_J = 25^{\circ}C$
- 4. Pulse test: PW \leq 300 μ s, duty cycle \leq 2%.
- 5. For DESIGN AID ONLY, not subject to production testing.
- 6. Switching time is essentially independent of operating temperature.

ORDERING INFORMATION

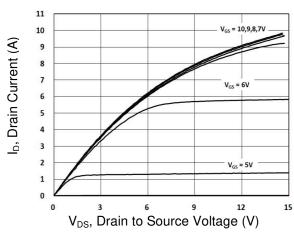
PART NO.	PACKAGE	PACKING
TSM60NB900CH C5G	TO-251 (IPAK)	75pcs / Tube



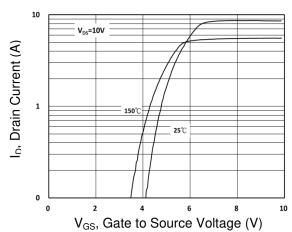
CHARACTERISTICS CURVES

 $(T_C = 25^{\circ}C \text{ unless otherwise noted})$

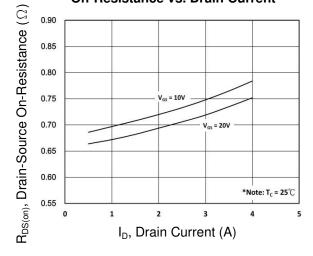
Output Characteristics



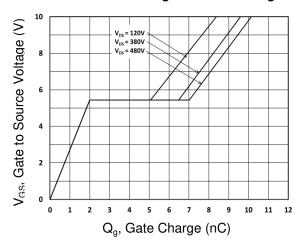
Transfer Characteristics



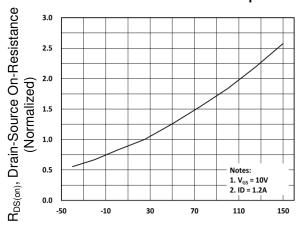
On-Resistance vs. Drain Current



Gate-Source Voltage vs. Gate Charge

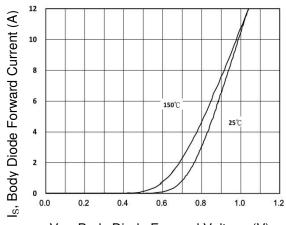


On-Resistance vs. Junction Temperature



T_{.J}, Junction Temperature (°C)

Source-Drain Diode Forward Current vs. Voltage



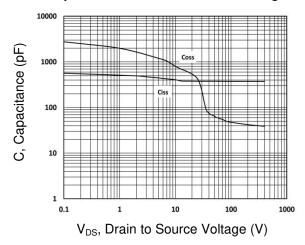
V_{SD}, Body Diode Forward Voltage (V)



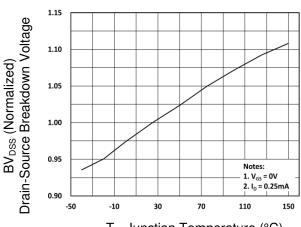
CHARACTERISTICS CURVES

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Capacitance vs. Drain-Source Voltage

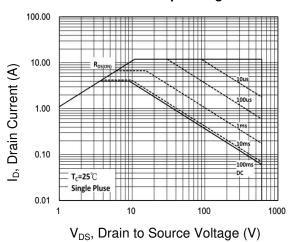


BV_{DSS} vs. Junction Temperature

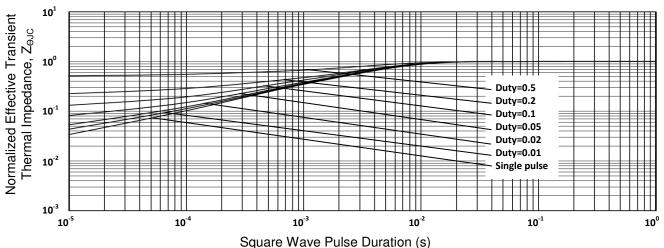


T_J, Junction Temperature (°C)

Maximum Safe Operating Area



Normalized Thermal Transient Impedance, Junction-to-Case

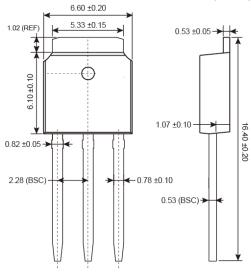


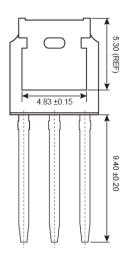




PACKAGE OUTLINE DIMENSIONS (Unit: Millimeters)

TO-251 (IPAK)





MARKING DIAGRAM



Y = Year Code

M = Month Code for Halogen Free Product

O =Jan P =Feb Q =

Q =Mar **R** =Apr

S =May **T** =Jun

U =Jul **V** =Aug

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 $W = Sep \quad X = Oct \quad Y = Nov \quad Z = Dec$

L = Lot Code $(1\sim9, A\sim Z)$



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